

#### **Characteristics**

Parameter	Rating	Units
Blocking Voltage	60	V <sub>P</sub>
Load Current, T <sub>A</sub> =25°C:		
With 5°C/W Heat Sink	11.85	Apc
No Heat Sink	4	ADC
On-Resistance (max)	0.08	Ω
Thermal Impedance, Junction-to-Case, θ <sub>JC</sub>	0.35	°C/W

#### **Features**

- 11.85A<sub>DC</sub> Load Current with 5°C/W Heat Sink
- Low 0.08Ω On-Resistance
- 60V<sub>P</sub> Blocking Voltage
- 2500V<sub>rms</sub> Input/Output Isolation
- Low Thermal Impedance: θ<sub>JC</sub> = 0.35 °C/W
- Isolated, Low Thermal Impedance Ceramic Pad for Heat Sink Applications
- Low Drive Power Requirements
- · Arc-Free With No Snubbing Circuits
- No EMI/RFI Generation
- Flammability Rating UL 94 V-0

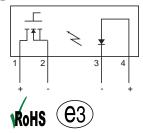
### **Applications**

- Industrial Controls / Motor Control
- Robotics
- Medical Equipment—Patient/Equipment Isolation
- Instrumentation
- Multiplexers
- Data Acquisition
- Electronic Switching
- I/O Subsystems
- · Meters (Watt-Hour, Water, Gas)
- Transportation Equipment
- Aerospace/Defense

## **Approvals**

- UL 508 Certified Component: File E69938
- CSA Certified Component: Certificate 1172007

## **Pin Configuration**



## **Description**

IXYS Integrated Circuits brings OptoMOS® technology, reliability and compact size to a new family of High Power Solid State Relays. As part of this new family, the CPC1708 single-pole normally open (1-Form-A) DC Solid State Relay employs optically coupled MOSFET technology to provide 2500V<sub>rms</sub> of input to output isolation.

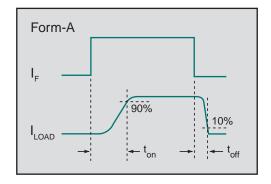
The relay output is constructed with efficient MOSFET switches that use IXYS Integrated Circuits' patented OptoMOS architecture. The input, a highly efficient infrared LED, controls the optically coupled output. Low on-resistance and high load current handling capability make this relay suitable for a variety of high performance DC switching applications.

The unique i4-PAC package pioneered by IXYS enables solid state relays to achieve the highest load current and power ratings. This package features an IXYS-unique process where the silicon chips are soft soldered onto the Direct Copper Bond (DCB) substrate instead of the usual copper leadframe. The DCB ceramic, the same substrate used in high power modules, not only provides 2500V<sub>rms</sub> isolation but also very low junction-to-case thermal impedance (0.35°C/W).

# **Ordering Information**

Part	Description
CPC1708J	i4-PAC Package (25 per tube)

# **Switching Characteristics**





# 1 Specifications

## 1.1 Absolute Maximum Ratings @ 25°C

Symbol	Ratings	Units
Blocking Voltage	60	$V_{P}$
Reverse Input Voltage	5	V
Input Control Current	50	mA
Peak (10ms)	1	А
Input Power Dissipation	150	mW
Isolation Voltage, Input to Output	2500	V <sub>rms</sub>
Operational Temperature	-40 to +85	°C
Storage Temperature	-40 to +125	°C

Absolute maximum ratings are stress ratings. Stresses in excess of these ratings can cause permanent damage to the device. Functional operation of the device at conditions beyond those indicated in the operational sections of this data sheet is not implied.

Typical values are characteristic of the device at +25°C, and are the result of engineering evaluations. They are provided for information purposes only, and are not part of the manufacturing testing requirements.

#### 1.2 Electrical Characteristics @ 25°C

Parameter	Conditions	Symbol	Minimum	Typical	Maximum	Units
Output Characteristics						
Load Current <sup>1</sup>						
Peak	t≤10ms				30	$A_P$
Continuous	No Heat Sink	ΙL			4	
Continuous	T <sub>C</sub> =25°C		-	-	24	A <sub>DC</sub>
Continuous	T <sub>C</sub> =99°C	I <sub>L(99)</sub>			5.35	
On-Resistance <sup>2</sup>	I <sub>F</sub> =10mA, I <sub>L</sub> =1A	R <sub>ON</sub>	-	0.05	0.08	Ω
Off-State Leakage Current	V <sub>L</sub> =60V <sub>P</sub>	I <sub>LEAK</sub>	-	-	1	μΑ
Switching Speeds						
Turn-On	I <sub>F</sub> =20mA, V <sub>I</sub> =10V	$t_{on}$	-	5	20	
Turn-Off	1F-2011/A, V[-10V	t <sub>off</sub>	-	0.13	5	ms
Output Capacitance	I <sub>F</sub> =0mA, V <sub>L</sub> =25V, f=1MHz	C <sub>out</sub>	-	1250	-	pF
Input Characteristics	•		•			
Input Control Current to Activate <sup>3</sup>	I <sub>L</sub> =1A	I <sub>F</sub>	-	-	10	mA
Input Control Current to Deactivate	-	I <sub>F</sub>	0.6	-	-	mA
Input Voltage Drop	I <sub>F</sub> =10mA	$V_{F}$	0.9	1.35	1.56	V
Reverse Input Current	V <sub>R</sub> =5V	I <sub>R</sub>	-	-	10	μΑ
Input/Output Characteristics						
Capacitance, Input-to-Output	V <sub>IO</sub> =0V, f=1MHz	C <sub>IO</sub>	-	1	-	pF

<sup>&</sup>lt;sup>1</sup> Higher load currents possible with proper heat sinking.

<sup>&</sup>lt;sup>2</sup> Measurement taken within 1 second of on-time.

<sup>&</sup>lt;sup>3</sup> For applications requiring high temperature operation (> 60°C) an LED drive current of 20mA is recommended.



#### **Thermal Characteristics**

Parameter	Conditions	Symbol	Rating	Units
Thermal Impedance (Junction to Case)	-	θЈС	0.35	°C/W
Thermal Impedance (Junction to Ambient)	Free Air	$\theta_{\sf JA}$	45	°C/W
Junction Temperature (Operating)	-	TJ	-40 to +100	°C

### 2.1 Thermal Management

Device high current characterization was performed using Kunze heat sink KU 1-159, phase change thermal interface material KU-ALC 5, and transistor clip KU 4-499/1. This combination provided an approximate junction-to-ambient thermal impedance of 12.5°C/W.

#### 2.2 Heat Sink Calculation

Higher load currents are possible by using lower thermal impedance heat sink combinations.

## **Heat Sink Rating**

$$\theta_{CA} = \frac{(T_{J} - T_{A}) |I_{L(99)}|^{2}}{|I_{L}|^{2} \cdot P_{D(99)}} - \theta_{JC}$$

T<sub>J</sub> = Junction Temperature (°C), T<sub>J</sub> ≤ 100°C \*

 $T_{\Delta}$  = Ambient Temperature (°C)

 $I_{L(99)}^{A}$  = Load Current with Case Temperature @ 99°C (A<sub>DC</sub>)  $I_{L}$  = Desired Operating Load Current (A<sub>DC</sub>),  $I_{L} \le I_{L(MAX)}$   $\theta_{JC}$  = Thermal Impedance, Junction to Case (°C/W) = 0.35°C/W

 $\theta_{CA}^{\circ}$  = Thermal Impedance of Heat Sink & Thermal Interface Material , Case to Ambient (°C/W)

 $P_{D(99)}$  = Maximum power dissipation with case temperature held at 99°C = 2.86W

**NOTE:** The exposed surface of the DCB substrate is not to be soldered.

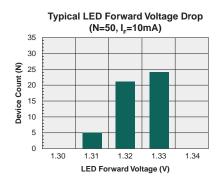
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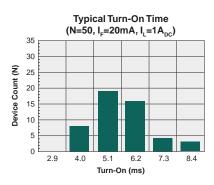
<sup>\*</sup> Elevated junction temperature reduces semiconductor lifetime.

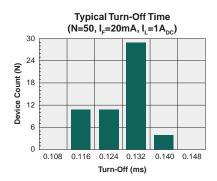


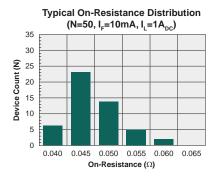
## 3 Performance Data\*

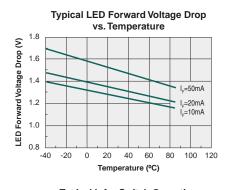
Unless otherwise specified, all data was collected without the use of a heat sink.

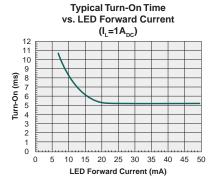


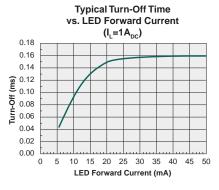


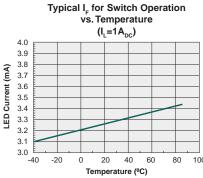


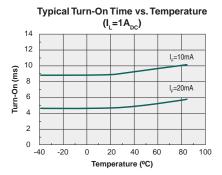


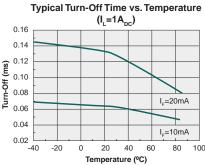










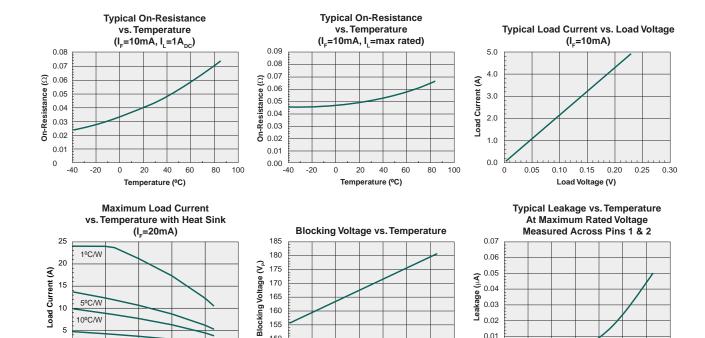


<sup>\*</sup> Unless otherwise noted, data presented in these graphs is typical of device operation at 25°C. For guaranteed parameters not indicated in the written specifications, please contact our application department.



Free Air 0 0

Temperature (°C)

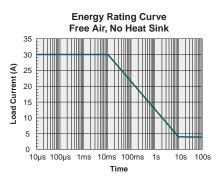


150

145

-40 -20

100



20 40 60 80 100

Temperature (°C)

0.01

-40

-20

20 40 60 80 100

Temperature (°C)

Unless otherwise noted, data presented in these graphs is typical of device operation at 25°C. For guaranteed parameters not indicated in the written specifications, please contact our application department.



# 4 Manufacturing Information

#### 4.1 Moisture Sensitivity

All plastic encapsulated semiconductor packages are susceptible to moisture ingression. IXYS Integrated Circuits classifies its plastic encapsulated devices for moisture sensitivity according to the latest version of the joint industry standard, **IPC/JEDEC J-STD-020**, in force at the time of product evaluation. We test all of our products to the maximum conditions set forth in the standard, and guarantee proper operare.

devices when handled according to the limitations and information in that standard as well as to any limitations set forth in the information or standards referenced below.

Failure to adhere to the warnings or limitations as established by the listed specifications could result in reduced product performance, reduction of operable life, and/or reduction of overall reliability.

This product carries a **Moisture Sensitivity Level (MSL)** classification as shown below, and should be handled according to the requirements of the latest version of the joint industry standard **IPC/JEDEC J-STD-033**.

Device	Moisture Sensitivity Level (MSL) Classification
CPC1708J	MSL 1

#### 4.2 ESD Sensitivity



This product is ESD Sensitive, and should be handled according to the industry standard JESD-625.

#### 4.3 Soldering Profile

Provided in the table below is the Classification Temperature ( $T_C$ ) of this product and the maximum dwell time the body temperature of this device may be ( $T_C$  - 5)°C or greater. The classification temperature sets the Maximum Body Temperature allowed for this device during lead-free reflow processes. For through-hole devices, and any other processes, the guidelines of **J-STD-020** must be observed.

Device	Classification Temperature (T <sub>C</sub> )	Dwell Time (t <sub>p</sub> )	Max Reflow Cycles
CPC1708J	245°C	30 seconds	1

**NOTE:** The exposed surface of the DCB substrate is not to be soldered.

#### 4.4 Board Wash

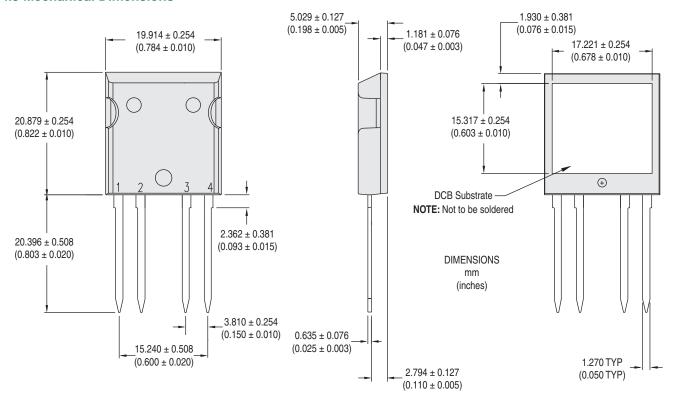
IXYS Integrated Circuits recommends the use of no-clean flux formulations. Board washing to reduce or remove flux residue following the solder reflow process is acceptable provided proper precautions are taken to prevent damage to the device. These precautions include but are not limited to: using a low pressure wash and providing a follow up bake cycle sufficient to remove any moisture trapped within the device due to the washing process. Due to the variability of the wash parameters used to clean the board, determination of the bake temperature and duration necessary to remove the moisture trapped within the package is the responsibility of the user (assembler). Cleaning or drying methods that employ ultrasonic energy may damage the device and should not be used. Additionally, the device must not be exposed to flux or solvents that are Chlorine- or Fluorine-based.







#### 4.5 Mechanical Dimensions



**NOTE:** Metallized external surface of DCB substrate maintains 2500V<sub>rms</sub> isolation to device internal structure and all external pins.

# For additional information please visit our website at: www.ixysic.com

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